SN54276, SN74276 QUADRUPLE J·K FLIP-FLOPS

- Four J·K Flip-Flops in a Single Package . . . Can Reduce FF Package Count by 50%
- Separate Negative-Edge-Triggered Clocks with Hysteresis . . . Typically 200 mV
- Typical Clock Input Frequency . . . 50 MHz
- Fully Buffered Outputs

description

These quadruple TTL J- \overline{K} flip-flops incorporate a number of third-generation IC features that can simplify system design and reduce flip-flop package count by up to 50%. They feature hysteresis at each clock input, fully buffered outputs, and direct clear capability, and are presettable through a buffer that also features an input hysteresis loop. The negative-edge-triggering clocks are directly compatible with earlier Series 54/74 single and dual pulse-triggered flip-flops. These circuits can be used to emulate D- or T-type flip-flops by hard-wiring the inputs, or to implement asychronous sequential functions.

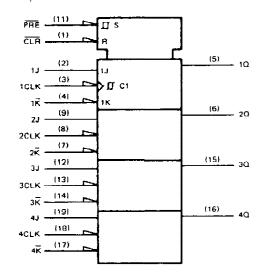
The SN54276 is characterized for operation over the full military temperature range of -55° C to 125° C; the SN74726 is characterized for operation from 0° C to 70° C.

COMMON INPUTS		INPUTS			OUTPUT		
PRE	CLR	CLK	ſ	ĸ	a		
L	н	x	х	х	н		
н	L	x	х	x	L		
L	L	x	х	х	н†		
н	н	4	L	н	0 ₀		
н	н	4	н	н	н		
н	н	I	L	L	L		
н	н	1	н	L	TOGGLE		
Н	н	н	×	×	0 ₀		

[†] This configuration is nonstable; that is, it may not oersist when preset and clear return to their inactive (high) level. OCTOBER 1976 - REVISED MARCH 1988

SN54276 J PACKAGE SN74276 N PACKAGE (TOP VIEW)							
CLR 1J 1CLK 1K 1Q 2Q 2CLK 2J GND	1 2 3 4 5 6 7 8 9 10	20 19 18 17 16 15 14 13 12 11	VCC 4J 4LK 4CLK 4R 30 3K 3CLK 9CLK 9CLK				

logic symbol[‡]

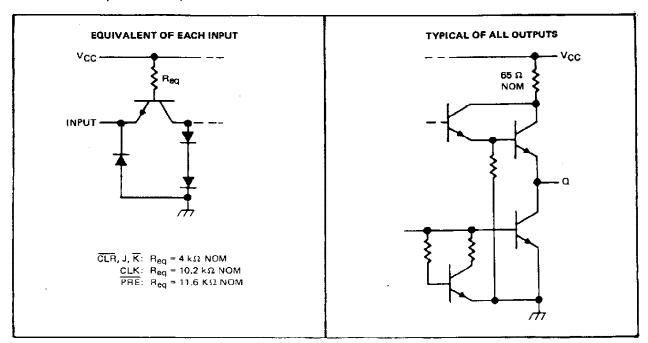


[‡]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

PRODUCTION DATA documents centain information current as of publication date. Products conform to specifications per the terms of Texes instruments standard warranty. Production processing daes not necessarily include testing of all parameters.



ST OFFICE BOX 655012 + DALLAS TEXAS 7576



schematics of inputs and outputs

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

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	SN54276	55°C to 125°C
Storage temperature range		— 65° C to 150° C
NOTE 1: Voltage values are with respect to netw	ork ground terminal.	



SN54276, SN74276 QUADRUPLE J-K FLIP-FLOPS

recommended operating conditions

		SN54276		SN74276				
	-	MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, VCC		4.5	5	5.5	4,75	5	5.25	V
High-level output current, IOH				800			-800	μA
Low-level output current, IOL		[16			16	mA
Clock frequency		0		35	0		35	MH
Pulse width, t _W	Clock high	13.5			13,5			ns
	Clock low	15			15			
	Preset or clear low	12			12			
Setup time, t _{su}	J, K inputs	31			34			ns
	Clear and preset inactive state	10↓			101			
Input hold time, th	· · · · · · · · · · · · · · · · · · ·	101			104			ns
Operating free-air temperature, TA		-55		125	0		70	⊃°

1 The arrow indicates that the falling edge of the clock pulse is used for reference.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	түр‡	MAX	UNIT
⊻н	High-level input voltage			2			V
VIL	Low-level input voltage					0.8	V
VIK	Input clamp voltage	V _{CC} = MIN,	1 ₁ = -12 mA			-1.5	V
∨он	High-level output voltage	V _{CC} = MIN, V _{IL} = 0.8 V,	V _{IH} ≈ 2 V, I _{OH} ≈ -800 µA	2.4	3.4		v
V _{OL}	Low-level output voltage	V _{CC} = MIN, V _{1L} = 0.8 V,	V _{IH} = 2 V, IOL = 16 mA		0.2	0,4	v
4	Input current at maximum input voltage	V _{CC} = MAX,	V ₁ = 5.5 V			1	mА
<u>,</u> Чн	High-level input current	VCC = MAX,	V1 = 2.4 V	[40	μA
ŧ۱L	Low-level input current	VCC - MAX,	V ₁ = 0.4 V	1		-1.6	mA
los	Short-circuit autput current §	V _{CC} = MAX		_30		85	mА
Icc	Supply current	V _{CC} = MAX		1	60	81	mA

[†]For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡All typical values are at V_{CC} = 5 V, T_A = 25°C.

 \S{Not} more than one output should be shorted at a time.

switching characteristics, V_{CC} = 5 V, T_A = 25 °C

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
fmax	Maximum clock frequency		35	50		MHz
¹ max ^t PLH	Propagation delay time, low-to-high-level output from preset	C _L = 15 pF.		15	25	ns
TPHL	Propagation delay time, high-to-low-level output from clear	$R_L = 400 \Omega$.		18	30	ns
tPLH	Propagation delay time, low-to-high level output from clock	See Note 2	L	17	30	ns
tPHL	Propagation delay time, high-to-low lèvel output from clock		<u> </u>	20	30	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



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